Search Notes

tion/Con	

Applicant(s)/Patent under Reexamination

09/938,106 Examiner

DERDERIAN, JAMES M.

Art Unit

Junghwa M. Im

2811

	SEARCHED				
Class	Subclass	Date	Examiner		
updated	orevious search	1/21/2007	JMI		
		·	,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		•		
		-		

DATE 1/21/2007	EXMR
1/21/2007	
	jmi
	_